


<b>Search Notes</b> 	<b>Application/Control No.</b> 10507180	<b>Applicant(s)/Patent Under Reexamination</b> DE BETHUNE ET AL.
	<b>Examiner</b> Cho, Jennifer Y	<b>Art Unit</b> 1621

SEARCHED			
Class	Subclass	Date	Examiner
562	430	5/5/08	JC
562	432	5/5/08	JC

SEARCH NOTES		
Search Notes	Date	Examiner
East Search	5/5/08	JC
Inventor Search	5/5/08	JC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
562	430	5/5/08	JC
562	432	5/5/08	JC